## U. S. DEPARTMENT OF COMMERCE Complete if Known PATENT AND TRADEMARK OFFICE 10/517,181 Application Number INFORMATION DISCLOSURE Filing Date December 7, 2004 STATEMENT BY APPLICANT (use as many sheets as necessary) Johannes Withelmus Eikenbroek First Named Inventor 2621 Art Unit Examiner Name Chikaodili E. Anyikire SHEET OF 1 Attorney Docket Number P15069-US1

U. S. PATENT DOCUMENTS				
Examiner's initials	Cite No.	Document Number (Number-Kind-Code)	Publication Date	Name of Patentee or Applicant of Cited Document
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Examiner's Initials	Cite No.	Foreign Patent Document (Country Code - Number - Kind)	Publication Date	Name of Patentee or Applicant of Cited Document	Translation
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NONPATENT LITERATURE DOCUMENT				
Examiner's Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazina, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	Т	
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Examiner Signature	A.	RAO		Date Considered	0/10/01

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